## **STN3N45K3**



# N-channel 450 V - 3.3 Ω typ., 0.6 A Zener-protected, SuperMESH3™ Power MOSFET in a SOT-223 package

Datasheet - production data

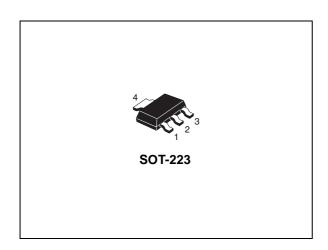
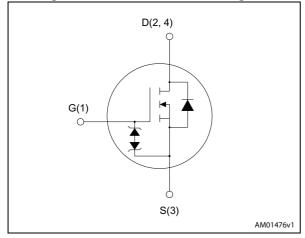


Figure 1. Internal schematic diagram



#### **Features**

| Order code | V <sub>DSS</sub> | R <sub>DS(on)</sub><br>max | I <sub>D</sub> | P <sub>w</sub> |
|------------|------------------|----------------------------|----------------|----------------|
| STN3N45K3  | 450 V            | < 4 Ω                      | 0.6 A          | 3 W            |

- 100% avalanche tested
- Extremely high dv/dt capability
- Gate charge minimized
- Very low intrinsic capacitance
- Improved diode reverse recovery characteristics
- Zener-protected

#### **Applications**

· Switching applications

#### **Description**

This SuperMESH3™ Power MOSFET is the result of improvements applied to STMicroelectronics' SuperMESH™ technology, combined with a new optimized vertical structure. This device boasts an extremely low onresistance, superior dynamic performance and high avalanche capability, rendering it suitable for the most demanding applications.

Table 1. Device summary

| Order code | Marking | Package | Packaging     |
|------------|---------|---------|---------------|
| STN3N45K3  | 3N45K3  | SOT-223 | Tape and reel |

Contents STN3N45K3

## **Contents**

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STN3N45K3 Electrical ratings

## 1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol                         | Parameter  | Value      | Unit |
|--------------------------------|--|------------|------|
| V <sub>DS</sub>                | Drain-source voltage (V <sub>GS</sub> = 0)   | 450        | V    |
| V <sub>GS</sub>                | Gate- source voltage   | ± 30       | V    |
| I <sub>D</sub>                 | Drain current (continuous) at T <sub>amb</sub> = 25 °C                                   | 0.6        | Α    |
| I <sub>DM</sub> <sup>(1)</sup> | Drain current (pulsed)   | 2.4        | Α    |
| P <sub>TOT</sub>               | Total dissipation at T <sub>amb</sub> = 25 °C  | 3          | W    |
| I <sub>AR</sub> (2)            | Avalanche current, repetitive or not-repetitive  | 0.6        | Α    |
| E <sub>AS</sub> (3)            | Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$ , $V_{DD} = 50$ V) | 45         | mJ   |
| dv/dt (4)                      | Peak diode recovery voltage slope  | 12         | V/ns |
| Vesd(g-s)                      | G-S ESD (HBM C = 100 pF, R = 1.5 k $\Omega$ )  | 1000       | V    |
| T <sub>stg</sub>               | Storage temperature  | -55 to 150 | °C   |
| Tj                             | Max. operating junction temperature  | 150        | °C   |

<sup>1.</sup> Pulse width limited by safe operating area.

Table 3. Thermal data

| Symbol                            | Parameter                           | Value | Unit |
|-----------------------------------|-------------------------------------|-------|------|
| R <sub>thj-a</sub> <sup>(1)</sup> | Thermal resistance junction-ambient | 37.8  | °C/W |

<sup>1.</sup> When mounted on FR-4 board of 1 inch<sup>2</sup>, 2oz Cu, t < 30 sec

<sup>2.</sup> Pulse width limited by Tj max.

<sup>3.</sup> Starting Tj = 25 °C,  $I_D = I_{AR}$ ,  $V_{DD} = 50 \text{ V}$ .

<sup>4.</sup>  $I_{SD} \leq 0.6 \text{ A}, \text{ di/dt } \leq 400 \text{ A/}\mu\text{s}, V_{DS} \text{ peak } \leq V_{(BR)DSS}, V_{DD} = 80\% \text{ } V_{(BR)DSS}.$ 

Electrical characteristics STN3N45K3

## 2 Electrical characteristics

(T<sub>C</sub> = 25 °C unless otherwise specified)

Table 4. On /off states

| Symbol   | Parameter | Test conditions  | Min. | Тур. | Max.    | Unit     |
|--|-----------|--|------|------|---------|----------|
| $V_{(BR)DSS}$ Drain-source breakdown voltage $I_D = 1$           |           | I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0                                 | 450  |      |         | V        |
|  |           | V <sub>DS</sub> = 450 V<br>V <sub>DS</sub> = 450 V, T <sub>C</sub> =125 °C |      |      | 1<br>50 | μA<br>μA |
| I <sub>GSS</sub> Gate-body leakage current (V <sub>DS</sub> = 0) |           | V <sub>GS</sub> = ± 20 V   |      |      | ± 10    | μΑ       |
| V <sub>GS(th)</sub> Gate threshold voltage                       |           | $V_{DS} = V_{GS}$ , $I_D = 50 \mu A$                                       | 3    | 3.75 | 4.5     | V        |
| Static drain-source on   |           | $V_{GS} = 10 \text{ V}, I_D = 0.6 \text{ A}$                               |      | 3.3  | 4       | Ω        |

Table 5. Dynamic

| Symbol                            | Parameter                             | Parameter Test conditions                              |   | Тур. | Max. | Unit |
|-----------------------------------|---------------------------------------|--|---|------|------|------|
| C <sub>iss</sub>                  | Input capacitance                     |  | - | 164  | -    | pF   |
| C <sub>oss</sub>                  | Output capacitance                    | $V_{DS} = 50 \text{ V, f} = 1 \text{ MHz, V}_{GS} = 0$ | - | 17   | -    | pF   |
| C <sub>rss</sub>                  | Reverse transfer capacitance          |  | - | 3    | -    | pF   |
| C <sub>o(tr)</sub> <sup>(1)</sup> | Equivalent capacitance time related   | $V_{DS} = 0$ to 360 V, $V_{GS} = 0$                    | - | 13   | -    | pF   |
| C <sub>o(er)</sub> <sup>(2)</sup> | Equivalent capacitance energy related | 1 V <sub>DS</sub> = 0 to 360 V, V <sub>GS</sub> = 0    | - | 18   | -    | pF   |
| R <sub>G</sub>                    | Intrinsic gate resistance             | f = 1 MHz open drain                                   | - | 8    | -    | Ω    |
| Qg                                | Total gate charge                     | V <sub>DD</sub> = 360 V, I <sub>D</sub> = 1.8 A,       | - | 9.5  | -    | nC   |
| $Q_{gs}$                          | Gate-source charge                    | V <sub>GS</sub> = 10 V                                 | - | 2    | -    | nC   |
| $Q_{gd}$                          | Gate-drain charge                     | (see Figure 16)  | - | 6    | -    | nC   |

<sup>1.</sup>  $C_{oss\,eq.}$  time related is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 

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<sup>2.</sup>  $C_{oss\ eq.}$  energy related is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 

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| Symbol              | Parameter           | Test conditions   | Min. | Тур. | Max | Unit |
|---------------------|---------------------|---|------|------|-----|------|
| t <sub>d(on)</sub>  | Turn-on delay time  |   | -    | 6.5  | -   | ns   |
| t <sub>r</sub>      | Rise time           | $V_{DD} = 225 \text{ V}, I_D = 0.9 \text{ A},$<br>$R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ | -    | 5.4  | -   | ns   |
| t <sub>d(off)</sub> | Turn-off-delay time | (see <i>Figure 15</i> )   | -    | 17   | -   | ns   |

Table 6. Switching times

Table 7. Source drain diode

| Symbol                          | Parameter                     | Test conditions   | Min. | Тур. | Max. | Unit |
|---------------------------------|-------------------------------|---|------|------|------|------|
| I <sub>SD</sub>                 | Source-drain current          |   | -    |      | 0.6  | Α    |
| I <sub>SDM</sub> <sup>(1)</sup> | Source-drain current (pulsed) |   | -    |      | 2.4  | Α    |
| V <sub>SD</sub> (2)             | Forward on voltage            | $I_{SD} = 0.6 \text{ A}, V_{GS} = 0$  | -    |      | 1.5  | V    |
| t <sub>rr</sub>                 | Reverse recovery time         | 1 0 0 1 1/1 100 0/  | -    | 175  |      | ns   |
| Q <sub>rr</sub>                 | Reverse recovery charge       | I <sub>SD</sub> = 1.8 A, di/dt = 100 A/μs<br>V <sub>DD</sub> = 60 V (see <i>Figure 20</i> ) | -    | 550  |      | nC   |
| I <sub>RRM</sub>                | Reverse recovery current      | 1 1 <sub>00</sub> = 33 1 (333 1 igal 2 2 )  | -    | 6    |      | Α    |
| t <sub>rr</sub>                 | Reverse recovery time         | I <sub>SD</sub> = 1.8 A, di/dt = 100 A/µs   | -    | 185  |      | ns   |
| Q <sub>rr</sub>                 | Reverse recovery charge       | $V_{DD} = 60 \text{ V}, T_j = 150 ^{\circ}\text{C}$   | -    | 600  |      | nC   |
| I <sub>RRM</sub>                | Reverse recovery current      | (see Figure 20)   | -    | 6.5  |      | Α    |

<sup>1.</sup> Pulse width limited by safe operating area.

Fall time

 $t_f$ 

Table 8. Gate-source Zener diode

| Syn              | nbol  | Parameter                     | Test conditions               | Min | Тур | Max | Unit |
|------------------|-------|-------------------------------|-------------------------------|-----|-----|-----|------|
| V <sub>(BR</sub> | R)GSO | Gate-source breakdown voltage | $I_{GS}$ = ± 1 mA, $I_{D}$ =0 | 30  | -   | -   | V    |

The built-in back-to-back Zener diodes have been specifically designed to enhance not only the device's ESD capability, but also to make them capable of safely absorbing any voltage transients that may occasionally be applied from gate to source. In this respect, the Zener voltage is appropriate to achieve efficient and cost-effective protection of device integrity. The integrated Zener diodes thus eliminate the need for external components.

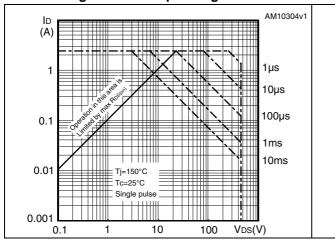
<sup>2.</sup> Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5%.

Electrical characteristics STN3N45K3

#### 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance



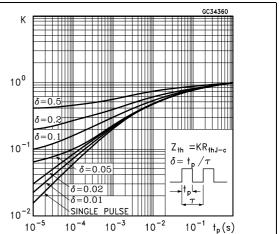
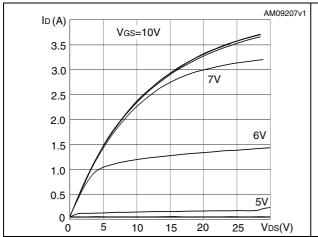


Figure 4. Output characteristics

Figure 5. Transfer characteristics



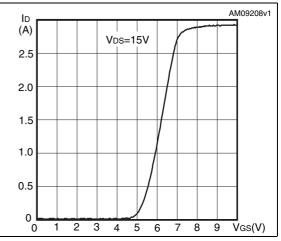
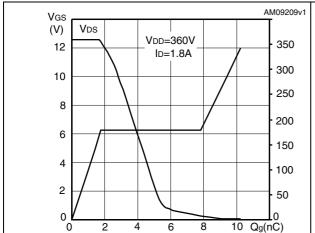
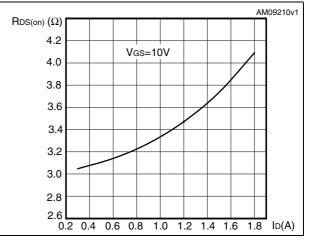


Figure 6. Gate charge vs gate-source voltage

Figure 7. Static drain-source on resistance





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Figure 8. Capacitance variations

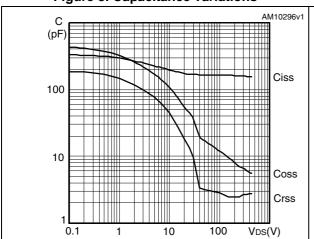


Figure 9. Output capacitance stored energy

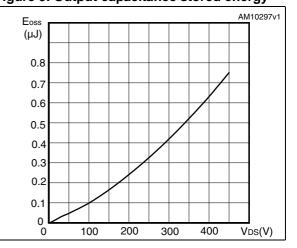
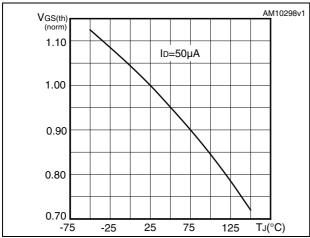


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on-resistance vs temperature



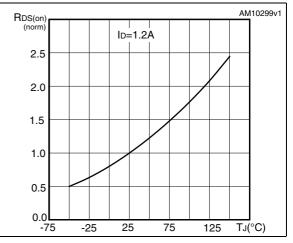
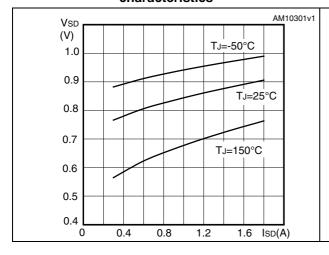
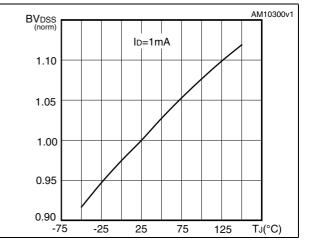


Figure 12. Source-drain diode forward characteristics

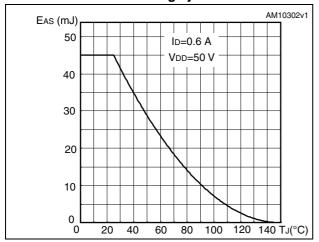
Figure 13. Normalized B<sub>VDSS</sub> vs temperature





Electrical characteristics STN3N45K3

Figure 14. Maximum avalanche energy vs starting Tj



STN3N45K3 Test circuits

#### 3 Test circuits

Figure 15. Switching times test circuit for resistive load

Figure 16. Gate charge test circuit

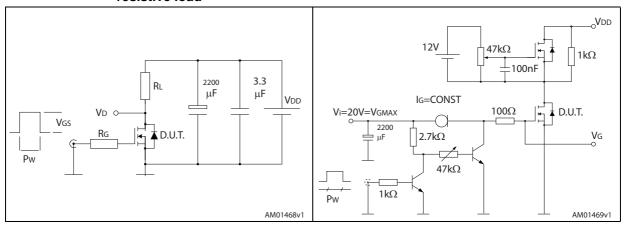


Figure 17. Test circuit for inductive load switching and diode recovery times

Figure 18. Unclamped inductive load test circuit

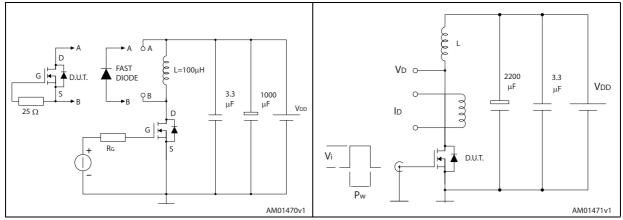
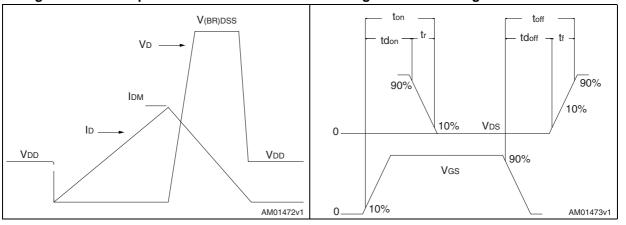


Figure 19. Unclamped inductive waveform

Figure 20. Switching time waveform



# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: <a href="https://www.st.com">www.st.com</a>. ECOPACK<sup>®</sup> is an ST trademark.

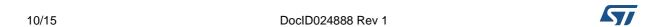
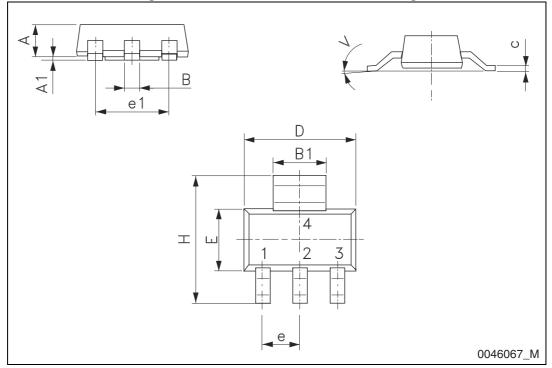


Table 9. SOT-223 mechanical data

| Dim. |      | mm   |      |
|------|------|------|------|
| Dim. | Min. | Тур. | Max. |
| А    |      |      | 1.80 |
| A1   | 0.02 |      | 0.1  |
| В    | 0.60 | 0.70 | 0.85 |
| B1   | 2.90 | 3.00 | 3.15 |
| С    | 0.24 | 0.26 | 0.35 |
| D    | 6.30 | 6.50 | 6.70 |
| е    |      | 2.30 |      |
| e1   |      | 4.60 |      |
| E    | 3.30 | 3.50 | 3.70 |
| Н    | 6.70 | 7.00 | 7.30 |
| V    |      |      | 10°  |

Figure 21. SOT-223 mechanical data drawing

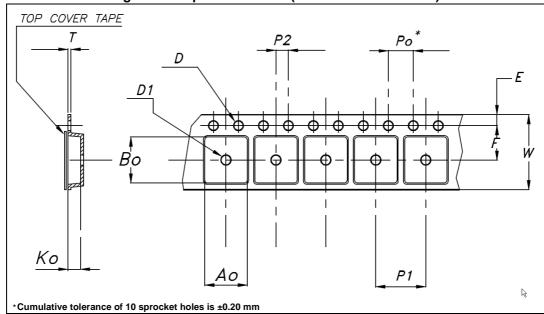


## 5 Packaging mechanical data

Table 10. SOT-223 tape and reel mechanical data

|        | Table 101 001 220 tape and 1001 moontained add |      |      |          |            |      |  |  |
|--------|--|------|------|----------|------------|------|--|--|
|        |  | Таре | Reel |          |            |      |  |  |
| Dim.   |  | mm   | mm   |          | m          | m    |  |  |
| Dilli. | Min.   | Тур. | Max. | Dim.     | Min.       | Max. |  |  |
| A0     | 6.75   | 6.85 | 6.95 | А        |            | 180  |  |  |
| В0     | 7.30   | 7.40 | 7.50 | N        | 60         |      |  |  |
| K0     | 1.80   | 1.90 | 2.00 | W1       |            | 12.4 |  |  |
| F      | 5.40   | 5.50 | 5.60 | W2       |            | 18.4 |  |  |
| E      | 1.65   | 1.75 | 1.85 | W3       | 11.9       | 15.4 |  |  |
| W      | 11.7   | 12   | 12.3 |          |            |      |  |  |
| P2     | 1.90   | 2    | 2.10 | Base qu  | antity pcs | 1000 |  |  |
| P0     | 3.90   | 4    | 4.10 | Bulk qua | antity pcs | 1000 |  |  |
| P1     | 7.90   | 8    | 8.10 |          |            |      |  |  |
| Т      | 0.25   | 0.30 | 0.35 |          |            |      |  |  |
| Dφ     | 1.50   | 1.55 | 1.60 |          |            |      |  |  |
| D1¢    | 1.50   | 1.60 | 1.70 |          |            |      |  |  |

Figure 22. Tape for SOT-223 (dimensions are in mm)



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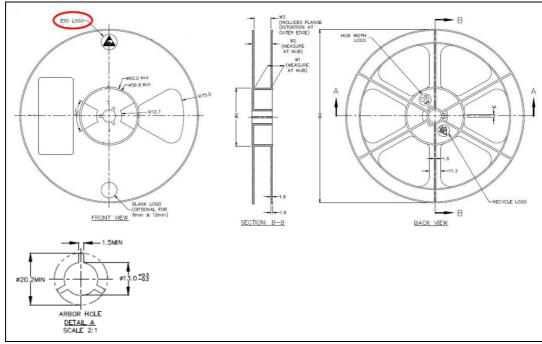


Figure 23. Reel for TO-223 (dimensions are in mm)



Revision history STN3N45K3

# 6 Revision history

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**Table 11. Document revision history** 

| Date        | Revision | Changes  |
|-------------|----------|--|
| 25-Jun-2013 | 1        | First release. Part number previously included in datasheet DocID17206 |

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